

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/535,284 KIRENKO ET AL.	
		Examiner	Art Unit Jared Beltowski	2621 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0233464	12-2003	Walpole et al.	709/231
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 2000 244872 A	09-2000	Japan	Kazuo et al.	H04N 5/92
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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